

Search Notes

Application/Control No.

10/500,098

Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

FRAME, ANNE D.

Art Unit

1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN:Indexed Bioscience cluster	2/8/2007	PL
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE	2/14/2007	PL
Inventor name search PALM/EAST	2/14/2007	PL
EAST (JPO,EPO,DERWENT,USPATFULL,U SPGPUBS,OCRBACKFILE) cont...	2/15/2007	PL